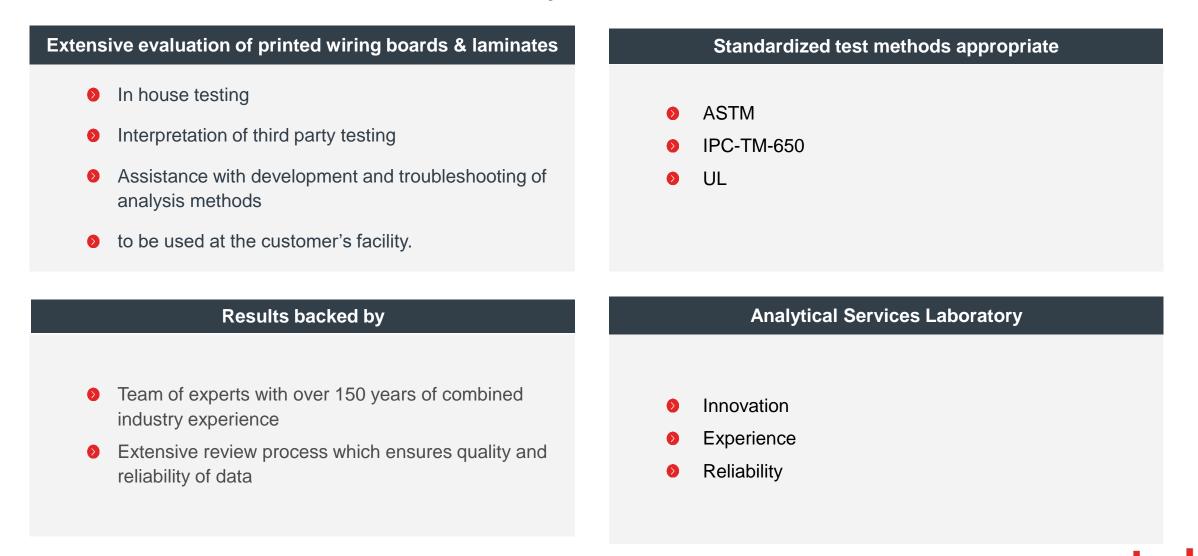
Test Capabilities

Chandler Johann Schumacher Laboratory (JSL) Services

isola

JSL Analytical Services



Sample, Submission & Results

Sample Submission

- Samples must be submitted via Isola Technical Services Representative
- Samples must be accompanied by Isola JSL a Lab Request Form (LRF)
- > Samples must be appropriately identified
- > Samples must meet the specific requirements for requested test as defined within this document

Results

> All results will be communicated by JSL to the Isola Technical Services Representative



Summary of Capabilities

Electrical, Thermal, Chemical, Physical & Specialty

- Dielectric Constant/Dissipation Factor (DK/DF)
 - > Bereskin Method
 - > IPC Method
 - > HP Method
 - > SPP
 - > Set2Dil
- Arc Resistance
- Dielectric Breakdown
- Electric Strength
- Surface and Volume



Dielectric Constant/Dissipation Factor (DK/DF)

- Dielectric Constant (DK): Measure of the energy storing capacity of a resin system resulting from polarization when an electric field is applied
- Dissipation Factor (DF): Measure of the loss rate of a resin system as it pertains to microwave energy
- DK/DF results reported reflect resin and glass and are therefore dependent on resin content of the sample

Bereskin Method

- > Frequency Range 50Mhz 13.5 Ghz
- Uses a resonating strip-line with fields in the Z-axis direction
- Measures DK and DF using Peak Max (DK) and -/+3db (DF)
- > Designed by Dr. Alexander Bereskin and used by Chandler
- > ASL under licensing agreement.

Sample Requirements

- > Two (2) Unclad laminates: 4.0" x 1.25 "
- > 0.020 "- 0.080" Thick
- > Free from all internal/external copper
- > External copper can be etched at the JSL

> Test Standards: Isola defined method.

Dielectric Constant/Dissipation Factor (DK/DF)

- Dielectric Constant (DK): Measure of the energy storing capacity of a resin system resulting from polarization when an electric field is applied
- Dissipation Factor (DF): Measure of the loss rate of a resin system as it pertains to microwave energy
- DK/DF results reported reflect resin and glass and are therefore dependent on resin content of the sample

Sample Requirements

- > Two (2) laminate samples required; 1 Large, 1 Small
 - ⊙ (Large) 2.7" x 1.9" x 0.060"
 - (Small) 2.7" x 1.8" x 0.060"
 - Up to 6 thin laminates may be stacked to meet thickness requirements +/- 0.003"
- > Free from all internal/external copper
- > External copper can be etched at the JSL

IPC Method

- > Frequency Range 10 Mhz 40.0 Ghz
- Uses a resonating strip-line with fields in the Z-axis direction
- > Industry standard developed by Robert Trout for IPC

Test Standards: IPC TM-650 Method 2.5.5.5

Dielectric Constant/Dissipation Factor (DK/DF)

- Dielectric Constant (DK): Measure of the energy storing capacity of a resin system resulting from polarization when an electric field is applied
- Dissipation Factor (DF): Measure of the loss rate of a resin system as it pertains to microwave energy
- DK/DF results reported reflect resin and glass and are therefore dependent on resin content of the sample

Hewlett Packard (HP)

- > Frequency . Range: 1.0 Mhz 1.8 Ghz
- Measures Z-axis capacitance using parallel plates for DK and DF determination.

Sample Requirements

- > One (1) unclad laminate 2.0" x 2.0"
- > Minimum Thickness: .008"
- > No Maximum Thickness
- > Free from all internal/external copper
- > External copper can be etched at the ASL

> Test Standards: IPC TM-650 Method 2.5.5.9

Dielectric Constant/Dissipation Factor (DK/DF)

- Determines rigid insulating material's ability to resist breakdown parallel to laminations
- Increasingly higher than normal voltage is applied to electrical components to determine the voltage where the insulation breaks down

Sample Conditioning

- > Condition A As Received
- Condition D48/50 –After immersion in 50°C water for 48 hours followed by D0.5/23 – immersion in 23°C water for 0.5 hour

Sample Requirements

> Printed wiring board manufactured to test specification

> Test Standards: IPC TM-650 Method 2.5.6

Dielectric Constant/Dissipation Factor (DK/DF)

- Determines rigid insulating material's ability to resist breakdown parallel to laminations
- Increasingly higher than normal voltage is applied to electrical components to determine the voltage where the insulation breaks down.

Hewlett Packard (HP)

- > Condition A As Received
- Condition D48/50 –After immersion in 50°C water for 48 hours followed by D0.5/23 – immersion in 23°C water for 0.5 hour

Sample Requirements

- > Four (4) Unclad laminates: 2.0" x 3.0 "
- > Thickness greater than 0.0199"
- > Free from all internal/external copper
- > External copper can be etched at the JSL

> Test Standards: IPC TM-650 Method 2.5.5.9

Electrical Strength

- Measures the electrical strength of a material as an insulator
- Defined as the maximum voltage required to produce a dielectric breakdown through the material
- Expressed as Volts per unit thickness.

Sample Conditioning

 Condition D48/50 –After immersion in 50°C water for 48 hours followed by D0.5/23 – immersion in 23°C water for 0.5 hour

Sample Requirements

- > Three (3) Unclad laminates: 3.5" x 3.5 "
- > Thickness less than 0.020"
- > Free from all internal/external copper
- > External copper can be etched at the JSL

> Test Standards: IPC TM-650 Method 2.5.6.2

Electrical Strength

- Measures the electrical strength of a material as an insulator
- Defined as the maximum voltage required to produce a dielectric breakdown through the material
- Expressed as Volts per unit thickness.

Hewlett Packard (HP)

 Condition D48/50 –After immersion in 50°C water for 48 hours followed by D0.5/23 – immersion in 23°C water for 0.5 hour

Sample Requirements

- > Laminate thickness of less than 0.51 mm [0.020 "]:
- > Three (3) samples
- > 50.8 ± 1.6 mm x 50.8 ± 1.6 mm
- $2.0" \pm 0.062" \times 2.0" \pm 1/16"$
- > Laminate thickness of 0.51 mm [0.020"] or greater.
- > Three (3) samples
- \rangle 101.6 \pm 3.2 mm x 101.6 \pm 3.2 mm
- > $4.0" \pm 0.062" \times 4.0' \pm 1/8"$

> Test Standards: IPC TM-650 Method 2.5.6.2

Surface and Volume Resistivity

- Determine surface and volume resistivity of metallic-clad or unclad laminates under conditions of specified humidity and temperature and at elevated temperatures.
- Samples are etched leaving copper circles to which leads are soldered for connection to the resistivity meter.

Sample Requirements

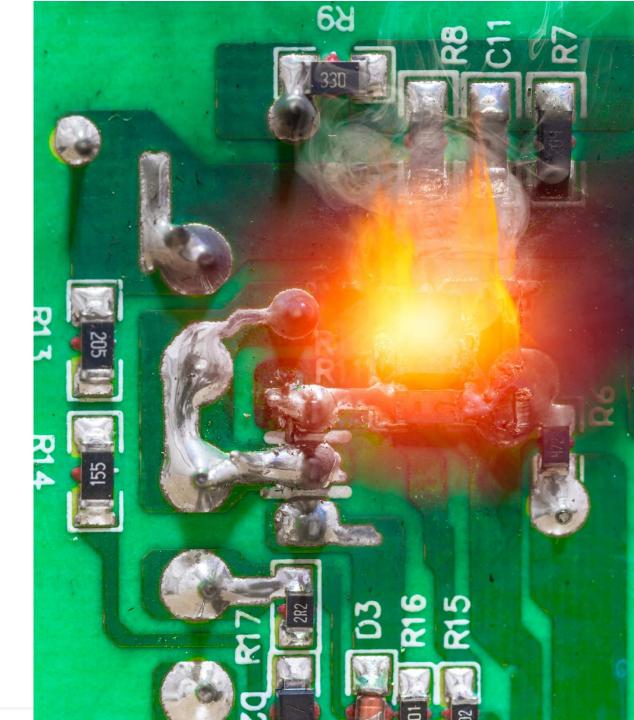
- > Laminate thickness of less than 0.51 mm [0.020 "]:
- > Three (3) samples
- $\rangle ~~50.8\pm1.6$ mm x 50.8 \pm 1.6 mm
- $2.0" \pm 0.062" \times 2.0" \pm 1/16"$
- > Laminate thickness of 0.51 mm [0.020"] or greater.
- > Three (3) samples
- > $101.6 \pm 3.2 \text{ mm x} 101.6 \pm 3.2 \text{ mm}$
- > $4.0" \pm 0.062" \times 4.0' \pm 1/8"$

Sample Conditioning

- > Condition A As Received
- > Condition F– Per IPC Standard
- Condition C96/35/90 After conditioning at 35°C/90% Relative Humidity for 96 hours
- Condition E24/XXX –After conditioning at XXX°C for 24 hours where XXX is defined by material slash sheet

> Test Standards: IPC TM-650 Method 2.5.17.1

- Glass Transition Temperature (Tg)
- Delta Tg by DSC & DMA
- Coefficient of Thermal Expansion (CTE)
- Time to Delamination
- Decomposition Temperature (Td)
- Weight Loss by TGA



Differential Scanning Calorimeter (DSC)

Measures the flow of heat into or out of a sample relative to a reference while heating the sample with a linear temperature ramp

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Sample Requirements

- > Multilayer laminates -2" x 2"
- Rigid Board laminates or PWB's optimal size 2" x 2"
- Minimum size –3mm x 3mm if sample has been cut to a good clean edge
- > 10mm x 10mm if ASL must remove any rough edges
- > Samples should be clad if possible

Glass Transition Temperature (Tg)

- Measure of the softening point of the amorphous molecules within the sample as indicated by the temperature at half height of the step change in heat flow
- > Ramp rate of 20°C/min

Delta Tg

- Measure of the softening point of the amorphous molecules within the sample as indicated by the temperature at half height of the step change in heat flow
- > Ramp rate of 20°C/min

> Test Standards IPC TM-650 Method 2.4.25

Dynamic Mechanical Analysis (DMA)

Detects changes in the storage modulus, loss modulus and tan delta of a material while heating the sample with a linear temperature ramp

Sample Requirements

- Laminates and Printed Wiring Boards –minimum sizes
 - \odot 2.5 3.5 mm thick : 5 mm wide x 60 mm long
 - \odot 1.5 2.5 mm thick : 9 mm wide x 45 mm long
 - O.25 1.5 mm thick : 11 mm wide x 35 mm long
- > No Copper in sample if possible
- > No Holes
- > No Solder
- > If samples are minimum size, edges must be clean and smooth

Glass Transition Temperature (Tg)

- Measure of the softening point of the amorphous molecules within the sample as indicated by the temperature at the onset of the change in CTE
- Ramp rate of 10°C/min

Delta Tg

- > Comparison of the Tg measured during the first heat of the sample to the
- > Tg when the sample is reheated. Depending upon the grade, the sample
- > may be held at an isothermal temperature above the Tg
- > Frequently considered a measure of the cure of the material
- > Ramp rate of 3°C/min

Thermomechanical Analysis(TMA)

Measures finite changes in the height of the sample related to the sample temperature

Sample Requirements

- Laminates and Printed Wiring Boards –minimum sizes
 - 2.5 3.5 mm thick : 5 mm wide x 60 mm long
 - 1.5 2.5 mm thick : 9 mm wide x 45 mm long
 - O.25 1.5 mm thick : 11 mm wide x 35 mm long
- > No Copper in sample if possible
- > No Holes
- > No Solder
- If samples are minimum size, edges must be clean and smooth

Glass Transition Temperature (Tg)

- Measure of the softening point of the amorphous molecules within the sample as indicated by the temperature of the peak in the tan delta
- Ramp rate of 3°C/min

Delta Tg

- Comparison of the Tg measured during the first heat of the sample to the Tg when the sample is reheated.
 Depending upon the grade, the sample may be held at an isothermal temperature above the Tg
- Frequently considered a measure of the cure of the material
- > Ramp rate of 3°C/min

Thermomechanical Analysis(TMA)

Measures finite changes in the height of the sample related to the sample temperature

Sample Requirements

- Rigid Board & Multilayer Laminates or PWB's optimal size 2" x 2"
 - Minimum size –8mm x 8mm if sample has been cut to a good clean edge
 - > 15mm x 15mm if JSL must remove any rough edges
- Laminate samples must be clad
- PWB Samples
 - > No Holes, No Solder

Time to Delamination

- Measure of the time at which separation of the internal layers of a sample occurs at a temperature of interest.
- Indication of the materials ability to withstand processing temperatures
- > Can be measured at any critical temperature
 - ➢ T-260
 - S T-288
 -) T-300
 - T-XXX



Thermogravimetric Analysis (TGA)

 Utilizes a microbalance to measure finite changes in weight as a sample is heated at a controlled rate

Sample Requirements

- Rigid Board & Multilayer Laminates or PWB's optimal size 2" x 2"
 - Minimum size –2mm x 2mm if sample has been cut to a good clean edge
 - 15mm x 15mm if JSL must remove any rough edges
- Laminate samples must free from all external and internal copper
 - Sector External copper can be etched at JSL
- > PWB Samples
 - > No Holes, No Solder, Minimal internal copper

Decomposition Temperature (Td)

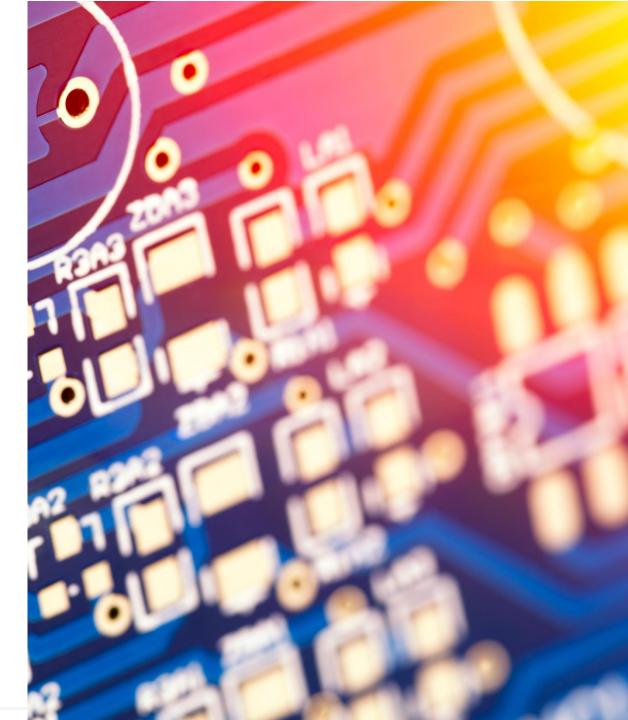
- The temperatures at which a sample loses 2% and 5% of its initial weight while heated at the method defined ramp rate
- Test Standard: IPC TM-650 Method 2.4.24.6 10°C/Minute
- > Test Standard: UL 746A Section 45 20°C/Minute

Weight Loss

> The percent of weight lost when a sample is held isothermally a defined temperature for a defined time

- Samples must be submitted via Isola Technical Services Representative
- Samples must be accompanied by Isola JSL a Lab Request Form (LRF)
- Samples must be appropriately identified
- Samples must meet the specific requirements for requested test as defined within this document

> Results: All results will be communicated by JSL to the Isola Technical Services Representative



Water Absorption

- Evaluates the resistance of dielectric materials to water
- Results reported as the percent increase in weight

Sample Conditioning

Condition D24/23 – After immersion in 23°C water for 24 hours

Sample Requirements

Three (3) Laminate Samples: 4" x 4"
Free from all internal/external copper
External copper can be etched at the JSL



Methylene Chloride Absorption

- Evaluates the resistance of dielectric materials to methylene chloride
- Results reported as the percent increase in weight

Sample Conditioning

 Condition D24/23 –After immersion in 23°C water for 24 hours

Sample Requirements

- > Three (3) Laminate Samples: 4" x 4"
- > Free from all internal/external copper
- > External copper can be etched at the JSL



Flammability

- Measures a material's ability to self-extinguish
- Materials tested to UL 94 for flammability V0

Sample Conditioning

Condition D24/23 – After immersion in 23°C water for 24 hours

Sample Requirements

- > Ten (10) Laminate Samples: 0.5" x 5.0"
- > Free from all internal/external copper
- > External copper can be etched at the JSL

> Test Standards: IPC TM-650 Method 2.6.16



Pressure Cooker

- Rapid evaluation of the laminate glass to resin integrity
- Test can only be performed on 1/16" material

Sample Conditioning

Condition D24/23 – After immersion in 23°C water for 24 hours

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Sample Requirements

- > Five (5) Laminate Samples: 4" x 4" x 1/16"
- > Free from all internal/external copper
- > External copper can be etched at the JSL

•) Test Standards: UL 94

Solder Float

Evaluates the time to delamination of copper clad materials when exposed to 288°C (550° F) solder

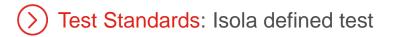
Sample Conditioning

Condition D24/23 – After immersion in 23°C water for 24 hours

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Sample Requirements

- > Three (3) Clad Laminate Samples: 2" x 2"
- > Free from all internal copper
- > External copper must be intact



Solderability

Evaluates a sample's ability to accept solder components

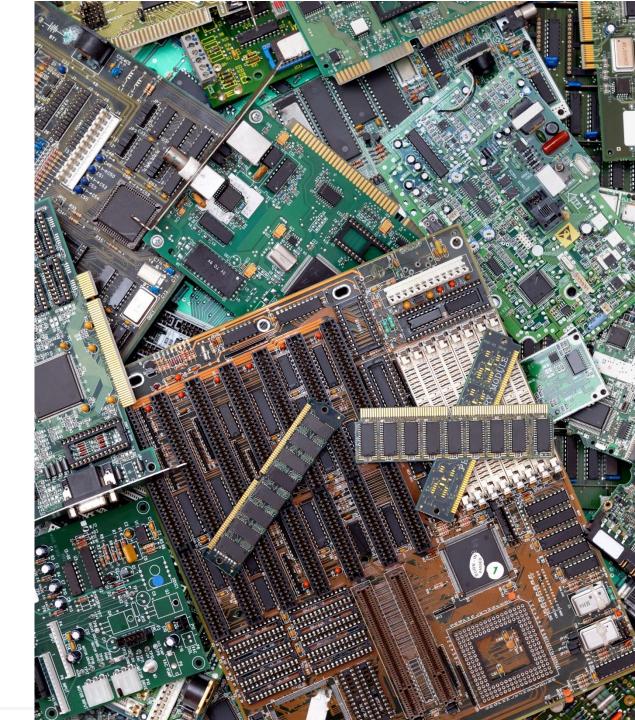
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Sample Requirements

- > Two (2) Clad Laminate Samples: 3" x 5"
- > Free from all internal copper
- > External copper must be intact

Test Standards: IPC-EIA/JEDEC J-STD-002B

- Retain Resin
- Ash Content
- Flexural Strength
- Tensile Strength
- Dimensional Stability
- Peel Strength
- Onstruction



Retain Resin

- Percent of the total weight sample which is resin
- Measured by comparing the weight loss after a burn off at 550°C to the original weight as a percentage

Ash Content

- Percent of the total weight sample which is not resin
- Measured by comparing the weight remaining after a burn off at 550°C to the original weight as a percentage

Sample Requirements – Laminates

- One (1) Laminate Sample: 2" x 2"
- Free from all internal/external copper
- External copper can be etched at the JSL

Sample Requirements – Prepregs

- Thin samples with low resin content, ie 1080 or 106 glass styles
 - Five (5) 2" x 2" samples
- All other prepregs
 - One (1) 2" x 2" sample

Test Standard

• IPC TM-650 Method 2.3.16



Retain Resin

- Percent of the total weight sample which is resin
- Measured by comparing the weight loss after a burn off at 550°C to the original weight as a percentage

Ash Content

- Percent of the total weight sample which is not resin
- Measured by comparing the weight remaining after a burn off at 550°C to the original weight as a percentage

Sample Requirements - Laminates

- > One (1) Laminate Sample: 2" x 2"
- > Free from all internal/external copper
- > External copper can be etched at the JSL

Sample Requirements - Prepregs

- Thin samples with low resin content, ie 1080 or 106 glass styles
 - \bigcirc Five (5) 2" x 2" samples
- > All other prepregs
 - One (1) 2" x 2" sample



Flexural Strength

- Determines the flexural strength of laminates by applying a specific load to a specific size and shaped specimen
- Results depend upon load force and sample size and shape
- Test can be completed at room or a defined elevated temperature

Sample Conditioning

Condition D24/23 – After immersion in 23°C water for 24 hours

Sample Requirements

- Sample requirements vary
- Refer to Table I in IPC-TM-650 number 2.4.4



Dimensional Stability

Determines the dimensional stability of glass reinforced, copper clad, thin laminates intended for use in multilayer printed wiring boards as they undergo etching and drying processes

Sample Conditioning

- Condition E4/105 After conditioning at 105°C for 4 hours
- Condition E2/150 After conditioning at 150°C for 2 hours

Sample Requirements

- Three (3) Laminate Samples: 12" x 12"
- Any thickness
- Free from all internal copper
- External copper must be intact



Peel Strength – At Elevated temperatures

- Measures the strength required to pull apart a bonded surface.
- Clad laminate samples are etched leaving strips of copper which are pulled from the laminate surface.
- Result is dependent on the sample thickness and speed of pulling force.
- > Three test methods available:
 - > At Elevated Temperature
 - > At Process Solutions
 - > After Thermal Stress

At Process Solutions & After Thermal Stress

- > Sample Requirements
 - Four (4) Laminate Samples: 2.5" x 2.5"
 - O Any thickness
 - External copper must be intact, strips will be etched by JSL
- > Test Standard
 - ◎ IPC TM-650 Method 2.4.13.1

The above minimum sample requirements are enough to run a single test. Please be aware that issues can arise that require samples to be retested. It is always recommended that enough sample be submitted to allow for 2 to 3 tests if possible.

At Elevated Temperature

- > Sample Requirements
 - > Four (4) Laminate Samples: 2.5" x 2.5"
 - O Any thickness
 - External copper must be intact, strips will be etched by JSL
- > Test Standard
 - () IPC-TM-650 2.4.8

Construction

Determines thread count of woven glass fabric of prepreg and the number of glass fabric of laminates and printed wiring boards

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Sample Requirements

- > Laminate Samples: 2" x 2"
- > Printed Wiring Board Samples: 2" x 2"
- > Prepreg Samples: 2" x 2"



Number of Plies of Glass Fabric in Laminate and Printed Wiring Boards

- Resin is removed from sample by muffle furnace burn off at 550°C
- > Layers of glass fiber are separated and counted

Determination of Tread Count

- > Evaluation of glass under Ginger thread counter, or,
- > Manual count of threads



- Profilometer
- FTIR
- Microsection
- Reflow
- Scanning Electron Microscope
- High Performance Liquid Chromatography
- Gel Permeation Chromatography



Fourier Transform Infrared Spectroscopy (FTIR)

- Analyzes the change in a beam of infrared light which has been focused onto a sample
- Uses the amount of energy absorbed by or transmitted through a sample over a frequency range to produce an IR Spectrum
- Uses extensive libraries to identify or characterize organic materials and contaminants

Sample Requirements

- > Raw Materials Solid or Liquid Form ~1 gram
- > Prepregs -1" x 1"
- > Printed Wiring Boards -1" x 1"
- > Laminates 1" x 1"
 - Samples can be etched at the JSL

Reporting Limitations

 FTIR Spectrum of standard materials will not be released

Microsection

- Evaluation of cross-sections of laminate and printed wiring board samples in a wide variety of configurations from surface to individual glass bundles
- > Thread count of glass weave can be determined
- Microscope has magnification of 20 to 1000 X
- Potting of samples allows precision polishing and grinding
 - > X Axis
 - > Y Axis
 - > Z Axis
- Sample conditioning available
 - > As received
 - > Thermal Stressed
 - > After reflow

Sample Limitation

- > Samples for potting
 - ⊘ Minimum: 0.5" x 0.5"
 - ⊘ Maximum: 1.5" x 1"
- > Z- Axis grind samples
 - Maximum: 6" x 6"



Reflow Oven

- Evaluation of the thermal integrity of circuit boards under repeated high heat conditions
- Same type of oven that is used in the industry to solder components to circuit boards
- Seven convection heating zones capable of running JEDEC reflow standards

Sample Requirements

- > Printed Wiring Boards or laminates
 - ⊙ Minimum: 2.0" x 2.0"
 - S Maximum: 18" x 24"

Mimic customer profiles

- > Lead or lead-free temperature profiles
- Accurate reproduction of profiles based on historical data of thermo-coupled boards
- Number of passes through oven defined by requestor

Evaluation of Samples

- Boards are visually inspected for delamination after every pass
- Cross-sections of failed or potential failed areas determine location of failure



Scanning Electron Microscopy (SEM)

- Evaluation of the thermal integrity of circuit boards under repeated high heat conditions
- Same type of oven that is used in the industry to solder components to circuit boards
- Seven convection heating zones capable of running JEDEC reflow standards

Energy Dispersive X-ray Spectroscopy (EDX)

- Identifies the elements on the scanned surface of the sample.
- Identifies the composition of the sample and inorganic contaminants

Sample Requirements

- > Raw materials Solid or powder form
- > Prepregs
- > Laminates minimum size 1" x 1"
- > Printed wiring boards minimum size 1" x 1"

High Performance Liquid Chromatography and Gel Permeation Chromatography (HPLC & GPC)

- HPLC: Separate the mixture of compounds to identify or quantify the individual component.
- GPC: Separate the mixture of compound to determine the molecular weight distribution or impurities.

Sample Requirements

> Sample in powder or liquid form around 1gram.

Sample Preparation & Conditioning

Sample Preparation

- Ability to accurately cut required test specimens from larger samples
 - > Programmable Router
 - > Diamond Saw
 - > Dremel
 - > Hand Shear
 - > Drill Press
 - > Belt Sander

Sample Conditioning

- Ability to meet test method conditioning requirements
 - > 8 High Temperature Ovens
 - > 3 Programmable Temperature and Humidity Chambers
 - > Desiccators
 - Immersion in DI Water at Controlled Temperatures

Thank You

